

30V N-Channel Trench MOSFET(Preliminary)

General Description			Product Summary			
 Trench Power technology Low R_{DS(ON)} Low Gate Charge High Current Capability 			V_{DS} $I_{D} (at V_{GS} = 10V)$ $R_{DS(ON)} (at V_{GS} = 10V)$ $R_{DS(ON)} (at V_{GS} = 4.5V)$	30V 160A < 1.8mΩ < 2.5mΩ		
 Applications Synchronous Rectification in DC/DC and AC/DC Control Isolated DC/DC Converters in Telecom and Industria 			100% UIS Tested	RoHS		
	то-220	9	G G S			
Part Number	Packa	де Туре	Form	Marking		
TTG160N03AT	то)-220	Tube	160N03AT		
Absolute Maximum Ra	tings (T₄ =2	5⁰C unless o	therwise noted)			
Parameter	<u> </u>	Symbol	Maximum	Units		
Parameter Drain-Source Voltage	• • •		1	Units V		
		Symbol	Maximum			
Drain-Source Voltage	$T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$	Symbol V _{DS}	Maximum 30	V		
Drain-Source Voltage Gate-Source Voltage	T _c =25°C	Symbol V _{DS} V _{GS}	Maximum 30 ±20 160	V V		
Drain-Source Voltage Gate-Source Voltage Continuous Drain Current ^A	T _c =25°C	Symbol V _{DS} V _{GS} I _D	Maximum 30 ±20 160 110	V V A		
Drain-Source Voltage Gate-Source Voltage Continuous Drain Current ^A Pulsed Drain Current ^A	T _c =25°C	Symbol V _{DS} V _{GS} I _D I _{DM}	Maximum 30 ±20 160 110 480	V V A A		
Drain-Source Voltage Gate-Source Voltage Continuous Drain Current ^A Pulsed Drain Current ^A Avalanche Current ^A Single Pulse Avalanche Energy	T _c =25°C T _c =100°C	Symbol V _{DS} V _{GS} I _D I _{DM} I _{AS} E _{AS}	Maximum 30 ±20 160 110 480 56	V V A A A A		
Drain-Source Voltage Gate-Source Voltage Continuous Drain Current ^A Pulsed Drain Current ^A Avalanche Current ^A	T _c =25°C T _c =100°C L =0.3mH ^A	Symbol V _{DS} V _{GS} I _D I _{DM} I _{AS}	Maximum 30 ±20 160 110 480 56 470	V V A A A MJ		
Drain-Source Voltage Gate-Source Voltage Continuous Drain Current ^A Pulsed Drain Current ^A Avalanche Current ^A Single Pulse Avalanche Energy	$T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$ $L = 0.3mH^{A}$ $T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$	Symbol V _{DS} V _{GS} I _D I _{DM} I _{AS} E _{AS}	Maximum 30 ±20 160 110 480 56 470 136	V V A A A M M W		
Drain-Source Voltage Gate-Source Voltage Continuous Drain Current ^A Pulsed Drain Current ^A Avalanche Current ^A Single Pulse Avalanche Energy Power Dissipation ^C	$T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$ $L = 0.3mH^{A}$ $T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$	Symbol V _{DS} V _{GS} I _D I _{DM} I _{AS} E _{AS} P _D	Maximum 30 ±20 160 110 480 56 470 136 68	V V A A A M M W W		
Drain-Source Voltage Gate-Source Voltage Continuous Drain Current ^A Pulsed Drain Current ^A Avalanche Current ^A Single Pulse Avalanche Energy Power Dissipation ^C Junction and Storage Temperatu	$T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$ $L = 0.3mH^{A}$ $T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$	Symbol V _{DS} V _{GS} I _D I _{DM} I _{AS} E _{AS} P _D	Maximum 30 ±20 160 110 480 56 470 136 68	V V A A A M M W W		
Drain-Source Voltage Gate-Source Voltage Continuous Drain Current ^A Pulsed Drain Current ^A Avalanche Current ^A Single Pulse Avalanche Energy Power Dissipation ^C Junction and Storage Temperatu Thermal Characteristics	$T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$ $L = 0.3mH^{A}$ $T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$	Symbol V _{DS} V _{GS} I _D I _{DM} I _{AS} E _{AS} P _D T _J , T _{STG}	Maximum 30 ±20 160 110 480 56 470 136 68 -55 to 175	V V A A A M M W W W V V		



Electrical Characteristics(T _J =25ºC unless otherwise noted)									
Sumbel Decomptor	Deremeter	Conditions		Value					
Symbol	Parameter			Min	Тур	Max	- Units		
STATIC P	ARAMETERS					-			
BV_{DSS}	Drain-Source Breakdown Voltage	$I_{D} = 250 \mu A, V_{GS} = 0V$		30			V		
		V _{DS} =30V, V _{GS} =0V	T _J =25⁰C			1	-μA		
I _{DSS} Ze	Zero Gate Voltage Drain Current		T _J =125°C			100			
I _{GSS}	Gate-Body Leakage Current	$V_{DS}=0V, V_{GS}=\pm 20V$				±100	nA		
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$		1	1.6	2.4	V		
D	Statia Drain Source On Desistance	V _{GS} =10V, I _D =30A			1.3	1.8	mΩ		
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =4.5V, I _D =30A		2.0	2.5	mΩ			
9 _{FS}	Forward Transconductance	V _{DS} =10V, I _D =20A			61		S		
V _{SD}	Diode Forward Voltage	I _S =30A, V _{GS} =0V				1	V		
ls	Maximum Body-Diode Continuous Curre	rent ^B				51	А		
DYNAMIC	PARAMETERS			_	-	-	_		
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =15V, f =1MH _Z			8826		pF		
C _{oss}	Output Capacitance				1320				
C _{rss}	Reverse Transfer Capacitance				1386				
R _g	Gate Resistance	f =1MH _z			1.7		Ω		
SWITCHI	NG PARAMETERS								
Q _g	Total Gate Charge	V _{GS} =10V,V _{DS} =15V, I _D =50A			177		nC		
Q _{gs}	Gate Source Charge				29				
Q_{gd}	Gate Drain Charge				35				
t _{D(on)}	Turn-On Delay Time	$V_{GS} = 10V, V_{DS} = 15V, I_{D} = 50A,$ $R_{G} = 3\Omega$			30		ns		
t _r	Turn-On Rise Time				29				
T _{D(off)}	Turn-Off Delay Time				101				
t _f	Turn-Off Fall Time				48				
t _{rr}	Body Diode Reverse Recovery Time	I _F =30A, di/dt =100A/µs			47		ns		
Q _{rr}	Body Diode Reverse Recovery Charge				43		nC		

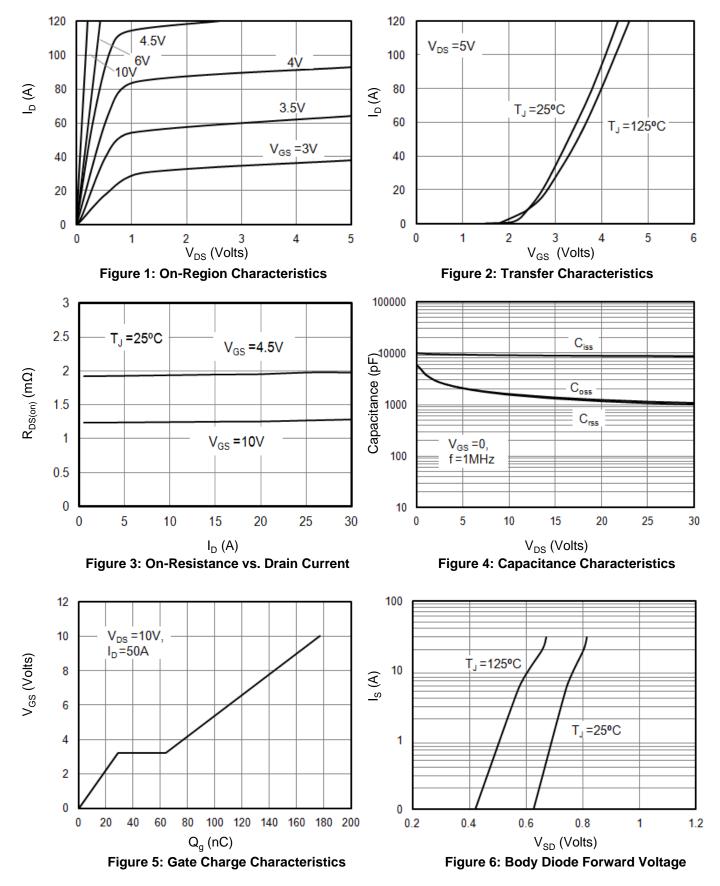
A. Single pulse width limited by maximum junction temperature.

B. The maximum current rating is package limited.

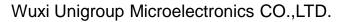
C. The power dissipation P_D is based on $T_{J(MAX)} = 175^{\circ}$ C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.



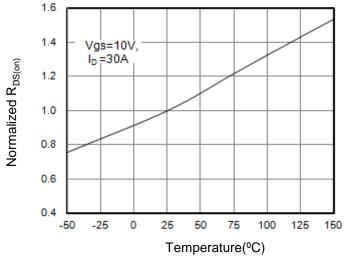
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

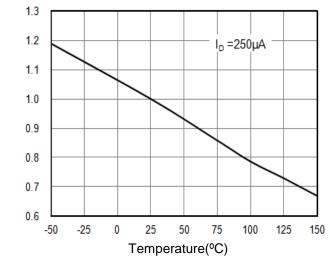


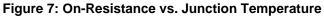


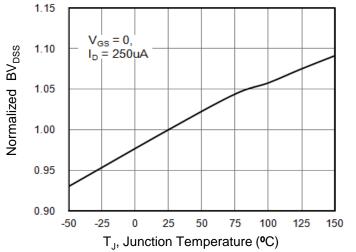


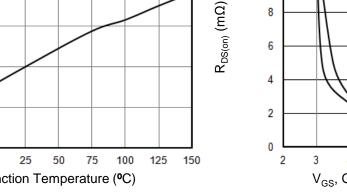
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS











Normalized Vgs(th)

Figure 9: BV_{DSS} vs. Junction Temperature

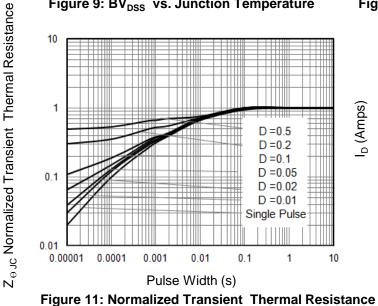


Figure 8: Vgs(th) vs. Junction Temperature

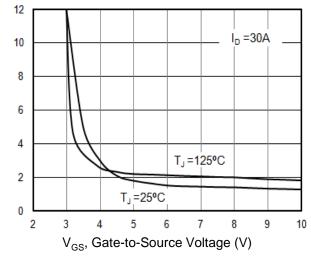
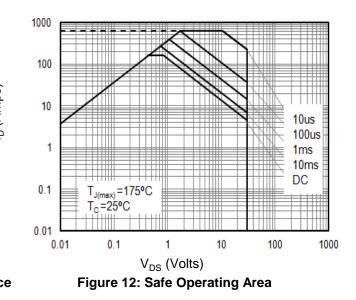
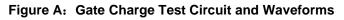
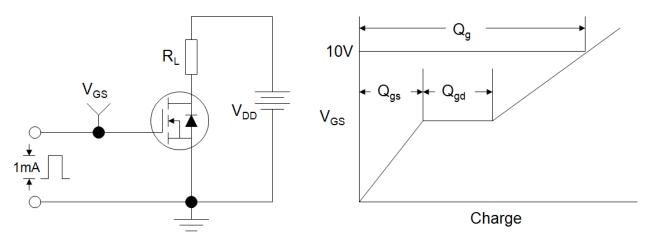
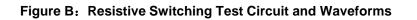


Figure 10: On-Resistance vs. Gate-Source Voltage









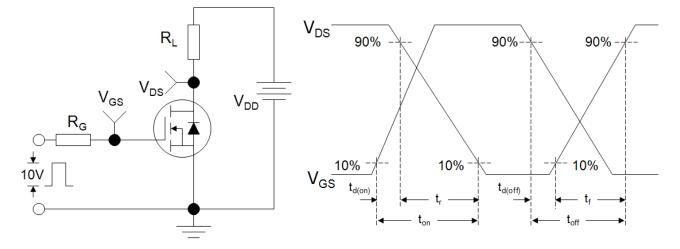
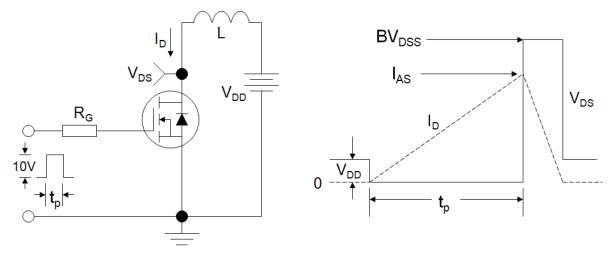
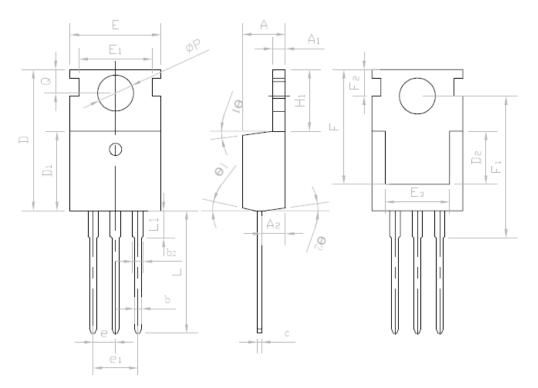


Figure C: Unclamped Inductive Switching (UIS) Test Circuit and Waveforms





TO-220(E)



SYMBOL	MIN	NOM	MAX		
Α	4.27	4.57	4.87		
A:	1.15	1.30	1.45		
A ₂	2.10	2.40	2.70		
Ъ	0.70	0.80	1.00		
b,	1.17	1.27	1.50		
с	0.40	0.50	0.65		
D	15.10	15.60	16.10		
D1	8.80	9.10	9.40		
D ₂	5.70	6.70	7.00		
E	9.70	10.00	10.30		
Eı	-	8.70	-		
E 2	9.63	10.00	10.35		
Es	7.00	8.00	8.40		
е	2.54 BSC				
e:	5.0	С			
Hı	6.00	6.50	6.85		
L	12.75	13.50	13.90		
L1	-	3.10	3.40		
øP	3.45	3.60	3.75		
Q	2.60	2.80	3.00		
Θ.	4•	7 •	10*		
Θ2	0*	3*	6*		
F	13.30	13.50	13.70		
F	15.50	15.90	16.30		
F ₂	2.80	3.00	3.20		



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